

Article **Fabrication of Hexagonal Microlens Arrays on Single-Crystal Silicon Using the Tool-Servo Driven Segment Turning Method**

Mao Mukaida and Jiwang Yan * [ID](https://orcid.org/0000-0002-5155-3604)

Department of Mechanical Engineering, Faculty of Science and Technology, Keio University,

3-14-1 Hiyoshi, Kohoku-ku, Yokohama 223-8522, Japan; mukaida@keio.jp

***** Correspondence: yan@mech.keio.ac.jp; Tel.: +81-45-566-1445

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Abstract: Single-crystal silicon microlens arrays are increasingly required in advanced infrared optics. In this study, the authors attempted to fabricate hexagonal microlens arrays, which offer high optical efficiency, on a single-crystal silicon wafer using diamond turning. A tool-servo driven segment turning method was proposed to reduce the dynamic error of the machine tool induced by lenslet edges during lens array cutting. From the results of both cutting experiments and theoretical analysis of the machine tool dynamic error, it was demonstrated that the segment turning method reduced significantly the dynamic errors and led to high form accuracy. As a result, sharp edges among the lenslets were generated precisely and microlens arrays with a form error of \sim 300 nm peak-to-valley and surface roughness of ~5 nmSa, which meets the requirements of infrared optical systems, were successfully fabricated. The subsurface damage, such as the amorphization of silicon, caused by machining was also reduced.

Keywords: single-crystal silicon; ultraprecision cutting; slow tool servo; microlens array; Infrared optics; ductile machining

1. Introduction

In recent years, infrared (IR) optical systems are increasingly demanded in many fields such as security and remote sensing. Single-crystal silicon is a typical substrate material for IR optics because of its high transmittance in the IR region. Although spherical and aspherical lenses of single-crystal silicon have been used in IR optical systems so far $[1-3]$ $[1-3]$, the silicon lens with its more complex shapes is in demand for future IR optical systems. For example, a microlens array can focus light on photodiodes in image sensors and homogenizers [\[4](#page-16-1)[–6\]](#page-16-2). Microlens arrays have been widely used in optical systems but currently most of them are made of glass and plastics, which are used only for visible or near-infrared lights. To date, there is very little literature on the fabrication of microlens arrays for IR systems.

In addition, silicon microlens arrays are also useable as micro mirrors for laser beam shaping [\[4\]](#page-16-1). Compared with other mirror materials, such as metal-coated glass substrates, single-crystal silicon is more suitable because of its high thermal conductivity. Another possible use of silicon microlens arrays is as the molds for press molding of glass micro optics [\[7\]](#page-16-3).

A few methods have been attempted for fabricating microlens arrays on silicon. Most of those methods are based on lithographic processes such as chemical etching [\[8–](#page-16-4)[10\]](#page-16-5) and laser assisted etching [\[4,](#page-16-1)[5\]](#page-16-6). However, the available lens geometries are very limited and it is difficult to ensure the form accuracy of the lens arrays.

On the other hand, mechanical machining technologies, such as ultraprecision cutting, have the advantages of high freedom of lens geometry, high form accuracy and low surface roughness [\[11\]](#page-16-7). In recent years, diamond turning using tool servos has enabled machining freeform surfaces by

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synchronizing the tool movement with the spindle rotation [\[11](#page-16-7)[–15\]](#page-16-8), which reduces machining time significantly compared to other cutting methods such as micro milling. There are two kinds of tool servos: a slow tool servo (STS) driven by a table of the machine tool and a fast tool servo (FTS) driven by a piezoelectric actuator in addition to the machine tool itself. Normally, an FTS is suitable for generating small-amplitude microstructures on flat or axially symmetrical surfaces; while an STS enables machining large-amplitude surface structures and high aspect ratio freeform surfaces. Also, STS systems are preferable for economic reasons because no extra machine add-ons are necessary for tool drive apart from the machine tool, unlike the FTS.

In a previous paper of the present authors, we succeeded in machining circular dimples on single-crystal silicon by STS diamond turning [\[16\]](#page-16-9). Independent circular lens dimples with high form accuracy were generated on silicon by ductile machining. To further increase the optical function, however, closely connected gapless microlens arrays are required. In this study, fabrication of hexagonal microlens arrays on single-crystal silicon was attempted. Hexagonal microlens arrays offer a fill factor of 100% and achieve higher light efficiency than circular lens arrays [\[17\]](#page-16-10).

However, hexagonal microlens arrays have many sharp edges at the boundaries among the lenslets, which makes the STS diamond turning very difficult because there is a significant dynamic error caused by the excessive acceleration of machine tables [\[18\]](#page-16-11). For this reason, up to date, STS diamond turning has only been used for machining continuous surfaces without edges [\[12](#page-16-12)[,19–](#page-16-13)[21\]](#page-16-14). A few researchers reported machining of microlens arrays using an STS [\[22](#page-16-15)[,23\]](#page-16-16), but the achieved form accuracy was low and no consideration was given to the edge-induced form error.

In this paper, a new STS diamond turning method, namely, segment turning method, for machining gapless hexagonal microlens arrays is proposed to improve lens form accuracy and edge generation. First, the effectiveness of the segment turning method will be experimentally evaluated by comparing with the conventional STS turning method in cutting hexagonal microlens arrays on an aluminum alloy. Ductile machining of hexagonal microlens arrays will then be attempted on single-crystal silicon by the segment turning method. The objective is to realize ductile machining of hexagonal microlens arrays on single-crystal silicon with low subsurface damage.

2. Mechanism of Segment Turning

Figure [1a](#page-2-0) shows a schematic diagram of an ultraprecision diamond turning lathe having an STS system and Figure [1b](#page-2-0) shows freeform surface machining by using the STS system. In STS turning, the *Z*-axis position of the tool is synchronized with the *C*-axis rotation of the workpiece, which means *Z* coordinate is a function of *X* and *C*. Conventionally, when machining concave microlens arrays, all lenslets are continuously machined in a single turning cycle, as shown in Figure [2a](#page-2-1). Continuous STS turning leads to excessive *Z*-axis acceleration at the sharp-edge boundaries among the lenslets and this causes dynamic errors of the machine tool. In this study, segment STS turning is proposed, as shown in Figure [2b](#page-2-1). In this method, the lenslets are divided into multiple groups where the lenslets in each group are separated from each other and each group of lenslets are machined in a single turning cycle. In this way, the sudden change in direction of the tool path is avoided, which reduces the *Z*-axis acceleration. It is expected that this method improves the motion accuracy of the machine tool and in turn, the resulting lens accuracy.

 $F = \begin{bmatrix} 1 & 0 & 0 \\ 0 & 0 & 1 \end{bmatrix}$ of $F = \begin{bmatrix} 0 & 0 & 0 \\ 0 & 0 & 0 \end{bmatrix}$ is a latter configuration; and (**b**) $F = \begin{bmatrix} 0 & 0 & 0 \\ 0 & 0 & 0 \end{bmatrix}$ **Figure 1.** Schematic of slow tool servo (STS) diamond turning: (a) lathe configuration; and (b) freeform machining.

Figure 2. Schematics of tool paths for two STS turning methods to generate a microlens array. **Figure 2.** Schematics of tool paths for two STS turning methods to generate a microlens array.

3. Effectiveness Verification of Segment turning 3. Effectiveness Verification of Segment turning

To investigate the effectiveness of segment turning method, hexagonal microlens arrays, which *3.1. Lens Design and Tool Path Generation 3.1. Lens Design and Tool Path Generation*

To investigate the effectiveness of segment turning method, hexagonal microlens arrays, turning, respectively and the results were compared. Figure 3 shows the results of a show the designed shows the comparative shape of a show the designed shape of a show of a show the shows the designed shape of a show of microcolens array. The workpiece was 10 mm in diameter and $\frac{10}{2}$ mm in diameter and a conceave spherical s radius of 25 mm and a hexagonal shape with a hexagonal shape with a side length of π a microlens array. The workpiece was 10 mm in diameter and each lenslet had a concave spherical surface with a radius of 25 mm and a hexagonal shape with a side length of 500 μ m. The lenslet sag was 5 μ m. The Cartesian coordinates (x, y, z) were set to the surface of the workpiece, while the cylindrical coordinates (X, Z, C) were set to the machine tool. Then, these coordinates have the which consist of sharp edges among lenslets, were machined by continuous STS turning and segment $\overline{}$ STS turning, respectively and the results were compared. Figure [3](#page-3-0) shows the designed shape of following relationships: following relationships:

$$
x = X\cos C \tag{1}
$$

$$
y = X \sin C \tag{2}
$$

$$
z = Z \tag{3}
$$

Tool path was then generated using the optics machining software DIFFSYS Figure 4 shows the dividend the divided lens divided lens (AMETEK Precitech Inc., Keene, NH, USA). The software enables tool radius compensation i generating tool paths. Figure 4a shows the distribution of divided lenslet groups in segr ng. In the present test cut, the whole lens array was divided into three groups which were educating. In the present lest eat, the whole lens alriay was arviated like three groups which were called the
sequentially. In a single turning cycle, circular lenslets were cut as [sh](#page-3-1)own in Figure 4b and then when generating tool paths. Figure [4a](#page-3-1) shows the distribution of divided lenslet groups in segment when generating tool paths. Figure 4a shows the distribution of divided lenslet groups in segment when generating tool paths. Tigate ta shows the distribution of divided rensier groups in segment turning. In the present test cut, the whole lens array was divided into three groups which were cut beyonal shape was formed by overlapping the circular lenslets as shown in Figure [4c](#page-3-1). In addition, hexagonal shape was formed by overlapping the circular lenslets as shown in Figure 4c. In addition, rexagonal shape was formed by overlapping the encludent refisieds as shown in Figure 4e. In detailed, the outer region of each lenslet had an approach zone for the tool as described by the dashed circle in over the circular lens of the circular lens as shown in Figure 4c. In addition, the outer region of the circular lens in t Figure [4b](#page-3-1) and the dashed line in Figure [4d](#page-3-1). The approach zone was designed to make the tool path Figure 4b and the tool path smooth without sharp turning points. In both continuous turning and segment turning, control points

(a control point is a member of a set of points used to determine the shape of a spline curve) were calculated at a constant angular step (2°) on the spiral tool path trajectory around the spindle axis. Linear interpolation was adopted among adjacent control points.

Figure 3. Lens array design for cutting experiments of comparison between segment turning and continuous turning. continuous turning. continuous turning.

in a single cycle; (c) generation of hexagonal shape; and (d) tool path for each lenslet. Figure 4. Tool path generation for segment turning: (a) schematic of segments; (b) dimples generated

3.2. Cutting Experiments

of \mathbf{u} m, a rake angle of \mathbf{u} rate angle of \mathbf{u} and \mathbf{v} was used. Cutting experiments were conducted. Cutting \mathbf{u} An ultraprecision diamond turning lathe Precitech Nanoform X (AMETEK Precitech Inc.) having an STS system was used in the experiments. A single-crystal diamond tool with a nose radius of 0.1 mm, a rake angle of 0° and a relief angle of 6° was used. Cutting experiments were conducted on an aluminum alloy A5056, on which tool movement can be well transferred. Oil mist was used for lubrication and cooling during cutting. The cutting parameters are summarized in Tab[le](#page-4-0) 1. In order to to compare the two methods in terms of cutting speed and machining time, the spindle rotation rate compare the two methods in terms of cutting speed and machining time, the spindle rotation rate (*N*) of continuous turning was set to two levels: one is the same as that of segment turning (45 rpm) and the other is one-third of that of segment turning (15 rpm), respectively.

Cutting Parameters	Values
Depth of cut Ap (μ m)	10 (roughing cut) 2 (finishing cut)
Spindle rotation rate N (rpm)	15, 45 (continuous STS turning) 45 (segment STS turning)
Feed per revolution $f(\mu m / rev)$	1
Cutting speed Vc (mm/s)	$0\neg 7.33$ $(N = 15)$ $0 \sim 23.5$ (N = 45)
Cutting tool	
Tool material	Single-crystal diamond
Nose radius (mm)	0.1
Rake angle $(^\circ)$	Ω
Relief angle $(°)$	6
Coolant	Oil mist

Table 1. Cutting conditions for a hexagonal microlens array on aluminum alloy.

3.3. Lens Topographical Error

Figure [5](#page-4-1) shows a photograph of a microlens array sample machined by segment STS turning at $N = 45$ rpm, which has a mirror finish. The sample surface was then observed using a differential interference contrast microscope. Figure [6](#page-5-0) shows microscope images of lenslets machined by continuous turning at different spindle rotation rates, as well as by segment turning. Two groups of images are shown: the lenslets around the workpiece center and those located at an outer region *3.3. Lens Topographical Error* around $x = 0$ mm and $y = 3.0$ mm. From these images, it is clear that the lens edges got blunt and disordered in continuous turning as the distance from the workpiece center increased. In contrast, very sharp edges were generated across the workpiece surface machined by segment turning. nh of a microlens array sample : or iinism. The samp. $C_{\rm P}$ contracts on $C_{\rm P}$ mistrix $C_{\rm P}$ in committee canning as the distance from the workprece center increased.

Next, the surfaces of the machined lens dimples were measured in detail using a laser-probe profilometer NH-3SP (Mitaka Kouki Co., Ltd., Tokyo, Japan). Figure [7](#page-5-1) shows three-dimensional topographies of lenslets the center of which are located at $x = 0$ mm, $y = 1.5$ mm in Figure 3 and cross-sectional profiles of lenslets measured along *x*-axis through the lenslet centers as indicated by the red dashed lines in the three-dimensional topographies. By comparing the theoretical profiles and the measured profiles, form error distributions were obtained and plotted in Figure [7.](#page-5-1) The results show that the peak-to-valley (P-V) value of the cross-sectional form error in segment turning was $0.35 \mu m$, 24% of that in continuous turning (1.44 μ m) at the same spindle rotation rate ($N = 45$ rpm) and 76% of that in continuous turning (0.46 μm) for the same machining time but at a lower spindle rotation rate ($N = 15$ rpm). This means that segment turning offers higher productivity than continuous turning. In addition, a large form error was found in the right side of the plots. Since the cutting direction was in the *x*-axis negative direction, the form error increased just after passing lenslet edges. Thus, it can be said that lenslet edges induced significant form errors and these form errors can be effectively reduced in segment turning. distribute in contrasted in contrast, the distribution of the work of the work process in contrast, in co topographies of lenslets the company are discretical promes and the measure 3 mm, $\frac{1}{2}$ μ _{th} the peak-to-value of the cross-section μ α - β experiment to α in section to α $t_{\rm crit}$ and $t_{\rm eff}$ plots. Since the ethning uncertain was fit the *r* thas negative uncertainty

Figure 5. Photograph of a hexagonal microlens array on aluminum alloy machined by segment STS turning at $N = 45$ rpm.

	Continuous turning $(N=45$ rpm)	Continuous turning $(N=15$ rpm)	Segment turning $(N=45$ rpm)
Outer lenslet $(y=3$ mm)			
Center lenslet			

 $500 \mu m$

Figure 6. Differential interference contrast microscope images of lenslets machined by continuous turning at different spindle rotation rates, as well as by segment turning.

Figure 7. Three-dimensional topographies and cross-sectional profiles of lenslets the centers of which are located at *x* = 0 mm, *y* = 1.5 mm. are located at *x* = 0 mm, *y* = 1.5 mm.

3.4. Measurement of Machine Tool Dynamic Error 3.4. Measurement of Machine Tool Dynamic Error

To investigate the dynamic errors of the machine tool, the *Z*-axis position was measured by To investigate the dynamic errors of the machine tool, the *Z*-axis position was measured by using using the real-time process monitoring system equipped in the machine tool itself and compared with the real-time process monitoring system equipped in the machine tool itself and compared with command position. Then, the *Z*-axis position error was calculated from the difference between the command position. Then, the *Z*-axis position error was calculated from the difference between the command position and the actual position and the *Z*-axis acceleration was calculated from the change command position and the actual position and the *Z*-axis acceleration was calculated from the change of the actual position, respectively. Figure 8 shows the plots of command positions, actual positions and accelerations in the left-side graphs and the plots of position errors in the right-side graphs. In the and accelerations in the left-side graphs and the plots of position errors in the right-side graphs. In figure, the measurements were performed during a period of 0.75 s after the tool passes the point *X* = 1.5 mm in order to compare with the profile error shown in Figure 7. *X* = 1.5 mm in order to compare with the profile error shown in Figur[e 7](#page-5-1).

Figure 8. Plots of command positions, actual positions and accelerations (left-side graphs), as well as **Figure 8.** Plots of command positions, actual positions and accelerations (left-side graphs), as well as position errors (right-side graphs) for continuous turning and segment turning. (a) Continuous turning $(N = 45$ rpm); (b) continuous turning $(N = 15$ rpm); (c) segment turning $(N = 45$ rpm). $(N = 45$ rpm); (**b**) continuous turning $(N = 15$ rpm); (**c**) segment turning $(N = 45$ rpm).

In continuous turning at *N* = 45 rpm, the absolute value of acceleration at the lenslet edges was In continuous turning at *N* = 45 rpm, the absolute value of acceleration at the lenslet edges was so large that it led to a significant delay in the Z-axis motion of the machine table $(1.37 \,\mu m$ P-V). When the spindle rotation rate is decreased to $N = 15$ rpm, the acceleration decreased too, causing a decrease in in the *Z*-axis position error to 0.35 μm P-V. However, in segment turning at *N* = 45 rpm, the the *Z*-axis position error to 0.35 µm P-V. However, in segment turning at *N* = 45 rpm, the acceleration was reduced by a factor of five compared to that in continuous turning at the same spindle rotation rate, spindle rotation rate, which accordingly reduced position error of cutting section (*Z* ≤ 3.75 μm) to which accordingly reduced position error of cutting section ($Z \leq 3.75 \,\mu m$) to 0.20 μm P-V. The trend of *Z*-axis position error was almost the same as that of the lens form error shown in Figure 7, which means the lens form error was mainly caused by the dynamic error of the machine tool. Figure 8 demonstrates strongly that even if the *Z*-axis acceleration can be reduced by decreasing the spindle rotation rate in continuous turning, it is still significantly higher than that in segment turning.

An important factor affecting lens edge formation is interpolation. In STS turning, a freeform surface is generated by calculating coordinates of a finite number of control points on the objective surface and interpolating between these points. Linear interpolation and spline interpolation are two major methods for interpolation. Spline interpolation is suitable for making a smooth tool path, but cannot be used to generate sharp edges. To generate a sharp edge by continuous STS turning, linear interpolation is necessary. However, as shown in Figure 9a, a sharp edge cannot be formed in continuous turning when the number of control points is not adequate to envelope the edge through linear interpolation. In segment turning, however, the tool path is not affected by interpolation method, as shown in Figure 9b. This greatly improves the edge accuracy. The differences in tool paths at lenslet edges between continuous turning and segment turning can be confirmed in the left-side graphs of Figure 8a–c. In addition, Figure 10 shows magnified cross-sectional profiles of lens edges at $y = 0.75$ mm measured using a white light interferometer Talysurf CCI1000 (AMETEK Taylor Hobson Ltd., Leicester, UK). In continuous turning (Figure 10a), the edge is very dull, with a radius of sev[era](#page-7-1)l hundred microns. In segment turning (Figure 10b), however, t[he](#page-7-1) edge becomes so sharp that the radius of which is hard to identify even at the available magnification of the white light interferometer used in this study. can not be used to generate sharp edge by a sharp edge by continuous strategy of $\frac{1}{2}$ that the radius of the while light interferometer used in this staty.

Figure 9. Effect of linear interpolation on lens edge formation for (a) continuous turning and (b) segment turning. segment turning. (**a**) Continuous turning; (**b**) segment turning. (**a**) Continuous turning; (**b**) segment turning. segment turning. (**a**) Continuous turning; (**b**) segment turning.

showing a blunt edge for (a) continuous turning and a sharp edge for (b) segment turning. $\sum_{i=1}^{n}$ continuous turning $\left(\frac{1}{n}\right)$ assumential turning $\left(\frac{1}{n}\right)$ segmential $\left(\frac{1}{n}\right)$ segmential turning $\left(\frac{1}{n}\right)$ segmential turning $\left(\frac{1}{n}\right)$ segmential turning $\left(\frac{1}{n}\right)$ segmential turnin turning. (**a**) Continuous turning (*N* = 45 rpm); (**b**) segment turning (*N* = 45 rpm). **Figure 10.** Magnified cross-sectional profiles of lens edges measured using a white light **Figure 10.** Magnified cross-sectional profiles of lens edges measured using a white light interferometer, (a) Continuous turning $(N = 45$ rpm); (**b**) segment turning $(N = 45$ rpm).

3.5. Modelling of Machine Tool Dynamic Error 3.5. Modelling of Machine Tool Dynamic Error 3.5. Modelling of Machine Tool Dynamic Error

it is important to establish a theoretical model for the control system. The actual control system of the STS machine tool might be very complex with a complicated transfer function [\[24\]](#page-16-17). In this study, for simplicity, the STS system was modeled as an open-loop system described by transfer function G according to the direct approach [\[25\]](#page-16-18), as shown in Figure [11.](#page-8-0) In order to predict the dynamic errors caused by an STS system in free form surface generation, α In order to predict the dynamic errors caused by an STS system in freeform surface generation,

To identify the transfer function *G*, the actual step response of the STS system was experimentally measured. A Z-axis displacement of 1 µm at a velocity of 1 mm/s was input to the machine tool as experimental website measured. A *Z*²axis displacement of 1 mm/s was input to the 1 mm/s was input to the 1 mm/s was input to the 1 mm of 1 mm at a velocity of 1 mm at a velocity of 1 mm at a velocity of 1 mm at a veloci $m_{\rm F}$ m $m_{\rm H}$ as a step in the the output was ϵ and the output process monitoring system of the function of the machine. The results are shown in Figure 12. Then, the transfer function *G* is assumed to be an a step input and the output was measured by the real-time process monitoring system of the machine.

The results are shown in Figure [12.](#page-8-1) Then, the transfer function *G* is assumed to be an ARX model as follows [\[25\]](#page-16-18):

$$
y(k) + a_1y(k-1) + \cdots + a_{n_a}y(k-n_a) = b_1u(k-1) + \cdots + b_{n_b}y(k-n_b) + w(k)
$$
 (4)

$$
A(q) = 1 + a_1 q^{-1} + \dots + a_{n_a} q^{-n_a}
$$
 (5)

$$
B(q) = b_1 q^{-1} + \dots + b_{n_b} q^{-n_b}
$$
 (6)

$$
y(k) = \frac{q^{-d}B(q)}{A(q)}u(k) + e(k) = G(q)u(k) + e(k)
$$
\n(7)

where $u(k)$ is input and $y(k)$ is output at time k, q is shift operator and $e(k)$ is disturbance at time k. Thus, the transfer function G can be determined by n_a , n_b , d and $a_1 \ldots a_{na}$, $b_1 \ldots b_{nb}$. These parameters were identified by least squares method fitting using the MATLAB System Identification Toolbox as step response of the identified transfer function meets the step response experimentally measured. Identified parameters are summarized in Table [2.](#page-8-2) The calculated step response with these parameters is Identified parameters are summarized in Table 2. The calculated step response with these parameters also shown in Figure 12 and it is confirmed that the calculated result matches well with the experiments. α parameters are summarized in Table 2. The calculated step response with these parameters $\frac{1}{2}$ denotes are summarized in Table 2. The calculated step response with these parameters inca parameters are same in Figure 12 and it is confirmed that the calculated result matches were used to the the rown in Figu

Figure 11. Block diagram of the feedback control system model for an STS system.

Figure 12. Measured and calculated step responses of the STS system.

Table 2. Identified parameters of the transfer function. **Table 2.** Identified parameters of the transfer function. **Table 2.** Identified parameters of the transfer function.

$n (d = 4)$	a_n	b_n
1	-1.4590	0.0332
2	-0.1072	-0.0424
3	0.5700	0.0160
4	0.3923	0.0360
5	-0.4839	-0.0609
6	-0.4312	0.0475
7	0.6291	0.0138
8	0.1703	-0.0914
9	-0.3175	0.0993
10	0.0401	-0.0477

Then, the model was used to calculate dynamic errors of various tool paths for microlens array Then, the model was used to calculate dynamic errors of various tool paths for microlens array machining. Two typical input tool paths as shown in Figure [13](#page-9-0) were used to generate lenslets having machining. Two typical input tool paths as shown in Figure 13 were used to generate lenslets having concave spherical surfaces with a depth of 5 μ m and a pitch of 1 mm. Control points were set at an interval of 50 μm along *X*-direction and linear interpolation was used. The tool path of segment turning included non-cutting sections between lenslets, the shape of which was the reversed lenslet turning included non-cutting sections between lenslets, the shape of which was the reversed lenslet shape. Cutting speed was set to 7 mm/s and 2.3 mm/s on the assumption of turning at spindle rotation rates $N = 45$ rpm and $N = 15$ rpm by a distance of 1.5 mm from the spindle rotation center. These conditions correspond to those of position error measurement shown in Figure [8.](#page-6-0)

Figure [14](#page-10-0) shows results of calculated *Z*-axis positions and position errors. In continuous turning, Figure 14 shows results of calculated *Z*-axis positions and position errors. In continuous turning, very large position errors occur at sharp edges even if the cutting speed is low. In segment turning, very large position errors occur at sharp edges even if the cutting speed is low. In segment turning, however, the P-V value of the position error is smaller than that in continuous turning; 33% of that however, the P-V value of the position error is smaller than that in continuous turning; 33% of that in continuous turning at the same cutting speed ($Vc = 7$ mm/s) and 97% of that at the one-third cutting speed (*Vc* = 2.3 mm/s). Under the same conditions, the measured P-V value of position error of speed (*Vc* = 2.3 mm/s). Under the same conditions, the measured P-V value of position error of segment turning was 15% and 57%, respectively, of that in continuous turning. Larger dynamic errors in the calculated models might be due to the control system simplification. In addition, the ultraprecision machine tool we used in this study had an STS control system involving adaptive control, where the control system was continuously optimized during machining and thus the dynamic errors were suppressed effectively.

The distribution of the calculated position error had similar tendency as that of the measured The distribution of the calculated position error had similar tendency as that of the measured results. From these facts, it might be said that the calculated results are comparable to the measured results. From these facts, it might be said that the calculated results are comparable to the measured results and machine tool position errors can be approximately estimated by the prediction model results and machine tool position errors can be approximately estimated by the prediction model used in this study. This model can help to generate tool path and decide machining parameters for used in this study. This model can help to generate tool path and decide machining parameters for non-rotationally symmetric surfaces. non-rotationally symmetric surfaces.

The findings from the present study demonstrated that by using the segment turning method, The findings from the present study demonstrated that by using the segment turning method, an ultraprecision machine tool equipped with an STS system can be directly used for fabricating high-precision freeform and structured surfaces having sharp edges, without need for introducing precision freeform and structured surfaces having sharp edges, without need for introducing machine add-ons such as FTS and so on. This will greatly extend the application fields of the STS-driven machine add-ons such as FTS and so on. This will greatly extend the application fields of the STSultraprecision machine tools in advanced manufacturing industries for optics, optoelectronics and micromechanical elements.

Figure 13. Input tool paths for calculating machine tool position errors when cutting concave spherical **Figure 13.** Input tool paths for calculating machine tool position errors when cutting concave spherical lenslets. (**a**) Continuous turning; (**b**) segment turning. lenslets. (**a**) Continuous turning; (**b**) segment turning.

(c) Segment turning, *Vc* = 7 mm/s

Figure 14. Calculated Z-axis positions (left-side graphs) and position errors (right-side graphs) for continuous turning and segment turning using an STS system. (**a**) Continuous turning, *Vc* = 7 mm/s; continuous turning and segment turning using an STS system. (**a**) Continuous turning, *Vc* = 7 mm/s; (**b**) continuous turning, *Vc* = 2.3 mm/s; (**c**) segment turning, *Vc* = 7 mm/s. (**b**) continuous turning, *Vc* = 2.3 mm/s; (**c**) segment turning, *Vc* = 7 mm/s.

4. Fabrication of Hexagonal Microlens Array on Single-Crystal Silicon 4. Fabrication of Hexagonal Microlens Array on Single-Crystal Silicon

4.1. Experimental Procedure 4.1. Experimental Procedure

Hexagonal microlens arrays were machined on a single-crystal silicon (001) wafer using the Hexagonal microlens arrays were machined on a single-crystal silicon (001) wafer using the segment STS turning method. The designed shape of the microlens array is shown in Figure 15, where the crystal orientation of silicon wafer is also indicated. Each lenslet has a concave spherical surface with a curvature radius of 2.563 mm and a hexagonal shape with a side length of 160 μ m. The lenslet sag is 5 μ m. The whole lens array was divided into three groups of lenslets, as described in Figure 15a. The [out](#page-11-0)er region of the lenslets had an approach zone as described by the dashed line circle in Figure [15b](#page-11-0).

Figure 15. Designed shape of silicon microlens array and tool path for its fabrication: (**a**) schematic of lenslets segment; (**b**) tool path for each lenslet. lenslets segment; (**b**) tool path for each lenslet.

The ultraprecision lathe Nanoform X (AMETEK Precitech Inc., Keene, NH, USA) having an STS system was used for the silicon cutting experiments as well. A single-crystal diamond tool with a nose radius of 1 mm, a rake angle of $-30°$ and a flank angle of 36° was used. Experimental conditions are summarized in [Ta](#page-11-1)ble 3. Feed rate *f* was determined based on the results of dimple cutting experiments as reported in Ref. [\[16\]](#page-16-9). In this experiment, control points were calculated at a constant angular step of 1° on the spiral tool path trajectory around the spindle axis and spline interpolation was adopted among adjacent control points to describe the ideal lenslet surface more precisely.

Cutting Parameters	Values
Depth of cut Ap (μ m)	$0 - 6$
Spindle rotation rate N (rpm)	40
Feed per revolution $f(\mu m / rev)$	1
Cutting speed Vc (mm/s)	$0 - 4.70$
Cutting tool Tool material Nose radius (mm) Rake angle $(^\circ)$ Relief angle $(°)$	Single-crystal diamond 1 -30 36
Coolant	Oil mist

Table 3. Cutting conditions for a hexagonal microlens array of single-crystal silicon. **Table 3.** Cutting conditions for a hexagonal microlens array of single-crystal silicon.

Figure 16 shows a photograph of a hexagonal microlens array having 58 lenslets machined on a *4.2. Lens form Accuracy*

Figure 16 shows a photograph of a hexagonal microlens array having 58 lenslets machined on a single-crystal silicon wafer (001) plane. It took about 2 h for machining. Figure 17 shows a differential interference contrast microscope image of the hexagonal microlens array. No cracks were found on the machined lenslet surfaces, which means the microlens arrays were successfully machined in a ductile mode. In addition, sharp edges among the lenslets were precisely generated by the segment T surface of the machined microlens array was then measured using a laser-probe α laser-probe α turning method.

The surface of the machined microlens array was then measured using a laser-probe profilometer NH-3SP (Mitaka Kouki Co., Ltd., Tokyo, Japan). Figure [18](#page-13-0) shows a three-dimensional topography and cross-sectional profile along the *x*-axis shown in Figure [15](#page-11-0) (white dashed line shown in Figure [18a](#page-13-0)). *Micromachines* **2017**, *8*, 323 13 of 18 It was confirmed that the lenslets have almost the same depth in the whole lens area.

The lenslet surface was further measured using a white light interferometer Talysurf CCI1000 The lenslet surface was further measured using a white light interferometer Talysurf CCI1000 (AMETEK Taylor Hobson Ltd., Leicester, UK) to evaluate its form error and surface roughness. (AMETEK Taylor Hobson Ltd., Leicester, UK) to evaluate its form error and surface roughness. Figure [19](#page-13-1) shows three-dimensional topographies and form error distributions of lenslets the center Figure 19 shows three-dimensional topographies and form error distributions of lenslets the center of which is located at $(x, y) = (0 \mu m, 480 \mu m)$ and $(0 \mu m, 960 \mu m)$ as shown in Figure [15.](#page-11-0) The P-V value of the form error measured was 270 nm (Figure [19a](#page-13-1)) and 249 nm (Figure [19b](#page-13-1)). The lenslet surface roughness was 4.8 nmSa (Figure [19a](#page-13-1)) and 4.9 nmSa (Figure [19b](#page-13-1)). The surface roughness was measured in a round area (diameter 300 µm) in lenslet centers and calculated by removing the lens measured in a round area (diameter 300 μm) in lenslet centers and calculated by removing the lens curvature and tilt. These results meet the requirement of infrared optical systems, as discussed in our curvature and tilt. These results meet the requirement of infrared optical systems, as discussed in our previous paper [\[16\]](#page-16-9). previous paper [16]. previous paper [16]. T_{F} T_{F} T_{F} and T_{F} is a weight interferometer T_{F} is a white T_{F} for T_{F} and T_{F} a white T_{F} and T_{F} and T_{F} are T_{F} and T_{F} and T_{F} are $\overline{\text{E}}$ $\overline{\text{E}}$ takes the surface dimensional to examples and form error distributions of longlets the senter. ϵ shows the legated at $(x, y) = (0, y, \ldots, 480, y, \ldots)$ and $(0, y, \ldots, 960, y, \ldots)$ as chown in Figure 15. The cent α _i) α of the form at an anomalyzed was 270 nm (Figure 19a) and 249 nm (Figure 16. The Poplet $\frac{1}{2}$ and $\frac{1}{2}$ nm ($\frac{1}{2}$ nm ($\frac{1}{2}$ nm ($\frac{1}{2}$) and $\frac{1}{2}$ nm ($\frac{1}{2}$) and $\frac{1}{2}$ nm ($\frac{1}{2}$) and $\frac{1}{2}$ nm (Figure 19b). The surface reuchases was rocaused in a round area (diameter $200 \text{ }\mu\text{m}$) in length centers and calculated by romaying the lang m round m and m in a round area (diameter a) in lenslet centers and calculated by removing the lenslet centers a and calculated by removing the lenslet centers a and calculated by removing the lenslet centers curvature and tilt. These requirement of infrared optical systems, as discussed in our our our our our our our

Figure 16. Photograph of a hexagonal microlens array machined on a single-crystal silicon wafer.

Figure 17. Differential interference contrast microscope image of the hexagonal microlens array.

Figure 18. Lens shape measurement results: (a) three-dimensional topography of a hexagonal microlens array; and (b) cross-sectional profile measured along the white dashed line shown in (a).

Figure 19. Three-dimensional topographies of lenslets at different locations and their form distributions. error distributions.

4.3. Evaluation of Subsurface Damage

In general, a subsurface damage layer containing amorphous silicon is generated when cutting single-crystal silicon due to the high pressure from the diamond tool [\[26\]](#page-17-0). This subsurface damage layer

may affect the optical performance of the resulting lens array, because its optical properties such as transmission rate and refractive index are different from those of single-crystal silicon. To confirm this, transmission rate and refractive index are different from those of single-crystal silicon. To confirm this,
laser micro-Raman spectroscopy [27] was performed to evaluate the degree of silicon amorphization on the machined lenslet surface. The excitation wavelength of the laser in Raman spectroscopy was 532 nm. Raman mapping measurements were performed as shown by the dots in Figure 20a. was 532 nm. Raman mapping measurements were performed as shown by the dots in Figure 20a.
Figure 20b,c show mapping results of the peak intensity for amorphous silicon (470 cm^{-[1](#page-14-0)}) for a l[ens](#page-14-0)let located at $y = 480$ μ m and 960 μ m. Compared with the mapping result for a circular dimple machined at a higher feed rate ($f = 6 \mu m / rev$) shown in Figure 20d, less amorphous silicon was detected. It is thought that the cutting force induced at a small feed rate was so small that it did not cause significant phase transformation of silicon. Thus, the machined microlens arrays in this study have negligible subsurface damage and maybe used in infrared optical systems without any subsequent processing like polishing.

spectrometer: (**a**) distribution of measurement points; (**b**) mapping result for the lenslet located at $x = 0$ μ m, $y = 480$ μ m and (c) $y = 960$ μ m; (d) is mapping result for a circular dimple at a higher feed rate (*f* = 6 μ m/rev), showing higher intensity. **Figure 20.** Mapping measurement of peak intensity of amorphous silicon using a laser micro-Raman

4.4. Tool Observation 4.4. Tool Observation

(*f* = 6 μm/rev), showing higher intensity.

The diamond tool was observed using a scanning electron microscope (SEM) after cutting hexagonal microlens arrays for a total cutting distance of 7.88 m. Figure [21](#page-15-1) shows microscopic images hexagonal microlens arrays for a total cutting distance of 7.88 m. Figure 21 shows microscopic images and an SEM image of the tool edge. Material adhesion was found on the flank face. This phenomenon and an SEM image of the tool edge. Material adhesion was found on the flank face. This phenomenon maybe caused by the decrease of effective relief angle when the tool cuts into a lenslet. An extremely maybe caused by the decrease of effective relief angle when the tool cuts into a lenslet. An extremely small relief angle leads to squeeze and adhesion of workpiece material onto the tool flank face. It is small relief angle leads to squeeze and adhesion of workpiece material onto the tool flank face. It is noteworthy that in Figure [21,](#page-15-1) no obvious tool wear was observed. This demonstrated that tool The diamond tool was observed using a scanning electron microscope (SEM) after cutting wear was insignificant for such a short cutting distance. Especially, in the segment turning method,

the tool/workpiece contact is intermittent, which enables the tool to be lubricated and cooled effectively. tool/workpiece contact is intermittent, which enables the tool to be lubricated and cooled effectively. As a result, tool wear is significantly reduced compared to that in continuous turning [\[28\]](#page-17-2). As a result, tool wear is significantly reduced compared to that in continuous turning [28].

Figure 21. Tool observation results: (a) microscope image of tool edge before cutting; (b) microscope image and (**c**) Scanning electron microscope (SEM) image of the tool edge after cutting hexagonal image and (**c**) Scanning electron microscope (SEM) image of the tool edge after cutting hexagonal microlens arrays on silicon. microlens arrays on silicon.

5. Conclusions 5. Conclusions

Segment turning using an STS system was proposed for machining microlens arrays with sharp Segment turning using an STS system was proposed for machining microlens arrays with sharp edges and its effectiveness was experimentally and analytically demonstrated. Hexagonal microlens edges and its effectiveness was experimentally and analytically demonstrated. Hexagonal microlens arrays were successfully fabricated on single-crystal silicon. The following conclusions were arrays were successfully fabricated on single-crystal silicon. The following conclusions were obtained.

- $\overline{}$ turning was reduced to 24% at the same spindle rotation rate and 76% for the same machining time, respectively. The segment turning method reduced significantly the *Z*-axis acceleration at lenslet boundaries and in turn, eliminated the dynamic errors of the machine tool. (1) Compared to continuous turning, the form error of the microlens array fabricated by segment
- (2) A simplified STS control model was proposed for predicting tool paths and position errors due to $\frac{1}{2}$ machine table acceleration and was experimentally verified.
- (3) Hexagonal silicon microlens arrays with a form error of ~300 nm P-V and surface roughness (3) Hexagonal silicon microlens arrays with a form error of ~300 nm P-V and surface roughness of of ~5 nmSa were successfully fabricated.
- $\frac{1}{2}$ $\frac{5}{2}$ $\frac{5}{2}$ $\frac{1}{2}$ $\frac{1}{2}$ (4) Hexagonal silicon microlens arrays were machined in a completely ductile mode with sharp (4) Hexagonal silicon microlens arrays were machined in a completely ductile mode with sharp edges at the boundaries of lenslets.
- edges at the boundaries of lenslets. (5) Raman spectroscopy of the lenslet surfaces showed that machining-induced amorphization of (5) Raman spectroscopy of the lenslet surfaces showed that machining-induced amorphization of silicon was reduced, indicating high surface integrity of the fabricated lenses. silicon was reduced, indicating high surface integrity of the fabricated lenses.

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